

Absolute Maximum Ratings

$T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Ratings	Units
V_{DSS}	Drain-Source Voltage	50	V
V_{GSS}	Gate-Source Voltage	± 20	V
I_D	Drain Current - Continuous	(Note 1a)	A
	- Pulsed	3.0	
P_D	Power Dissipation for Single Operation	2.0	W
	Power Dissipation for Single Operation	1.6	
		1	
	(Note 1c)	0.9	
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ\text{C}$

Thermal Characteristics

R_{QJA}	Thermal Resistance, Junction-to-Ambient	62.5	$^\circ\text{C/W}$
R_{QJC}	Thermal Resistance, Junction-to-Case (Note 1)	40	$^\circ\text{C/W}$

Package Outlines and Ordering Information

Device Marking	Device	Reel Size	Tape Width	Quantity
9955	SI9955DY	13"	12mm	2500 units

* Die and manufacturing source subject to change without prior notification.

Electrical Characteristics

$T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
--------	-----------	-----------------	-----	-----	-----	-------

Off Characteristics

BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	50			V
ΔBV_{DSS} ΔT_J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$, Referenced to 25°C		60		$\text{mV}/^\circ\text{C}$
I_{DSs}	Zero Gate Voltage Drain Current	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55^\circ\text{C}$			2 25	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA

On Characteristics (Note 2)

$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	1			V
$\Delta V_{GS(th)}$ ΔT_J	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$, Referenced to 25°C		-4.5		$\text{mV}/^\circ\text{C}$
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}, T_J = 125^\circ\text{C}$ $V_{GS} = 4.5 \text{ V}, I_D = 1.5 \text{ A}$		0.076 0.124 0.103	0.130 0.200 0.200	Ω
$I_{D(on)}$	On-State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$	10			A
g_{FS}	Forward Transconductance	$V_{DS} = 15 \text{ V}, I_D = 3 \text{ A}$		5.3		S

SI9955DY

N-Channel Enhancement Mode MOSFET



AMERICAN
MICROSEMICONDUCTOR

Advancing the Semiconductor Industry Since 1972

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$	345		pF
C_{oss}	Output Capacitance		110		pF
C_{rss}	Reverse Transfer Capacitance		25		pF

Switching Characteristics (Note 2)

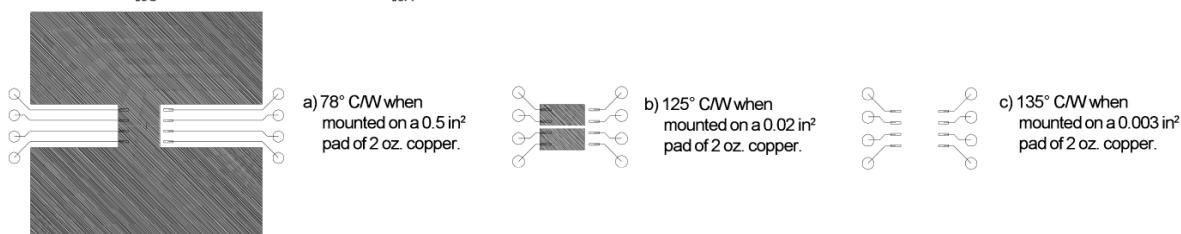
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 25 \text{ V}, I_D = 1 \text{ A}, R_L = 25 \Omega$ $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	5	20	ns
t_r	Turn-On Rise Time		7.5	20	ns
$t_{d(off)}$	Turn-Off Delay Time		20	70	ns
t_f	Turn-Off Fall Time		7	50	ns
t_{rr}	Drain-Source Reverse Recovery Time	$I_F = 1.5 \text{ A}, di/dt = 100 \text{ A}/\mu\text{s}$	40	100	nS
Q_g	Total Gate Charge	$V_{DS} = 25 \text{ V}, I_D = 2 \text{ A},$ $V_{GS} = 10 \text{ V}$	13	30	nC
Q_{gs}	Gate-Source Charge		1.7		nC
Q_{gd}	Gate-Drain Charge		3.2		nC

Drain-Source Diode Characteristics and Maximum Ratings

I_S	Maximum Continuous Drain-Source Diode Forward Current			2.0	A	
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 1.5 \text{ A}$ (Note 2)		0.8	1.2	V

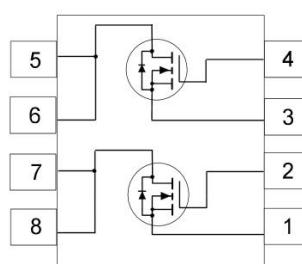
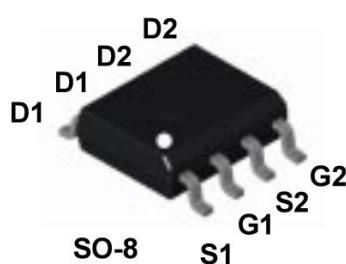
Notes:

1. R_{QJA} is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{QJC} is guaranteed by design while R_{QJA} is determined by the user's board design.



Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 2.0\%$



Tel. 1-973-377-9566, Fax. 1-973-377-3078

133 Kings Road,
Madison, New Jersey 07940
United States of America

© 2013 American Microsemiconductor, Inc.
Specifications are subject to change without notice.

www.americanmicrosemi.com

Document Page 2 of 2

Revised 06/2013

Aerospace Mgmt. Sys. Cert.
AS/EN/JISQ9100:2009 Rev. C

ISO9001:2008
Cert No. 45325

